

**20-Bit Universal Bus Driver  
with 3-State Outputs**
**Product Features**

- PI74ALVC162836 is designed for low-voltage operation,  $V_{CC}=2.3\text{V}$  to  $3.6\text{V}$
- Supports PC100 Registered DIMM
- Typical  $V_{OLP}$  (Output Ground Bounce)  $<0.8\text{V}$  at  $V_{CC}=3.3\text{V}$ ,  $T_A=25^\circ\text{C}$
- Typical  $V_{OHV}$  (Output  $V_{OH}$  Undershoot)  $<2.0\text{V}$  at  $V_{CC}=3.3\text{V}$ ,  $T_A=25^\circ\text{C}$
- Outputs have equivalent 26-ohm series resistors
- Industrial operation at  $-40^\circ\text{C}$  to  $+85^\circ\text{C}$
- Packages available:
  - 56-pin 240 mil wide plastic TSSOP (A)
  - 56-pin 173 mil wide plastic TVSOP (K)
  - 56-pin 300 mil wide plastic SSOP (V)

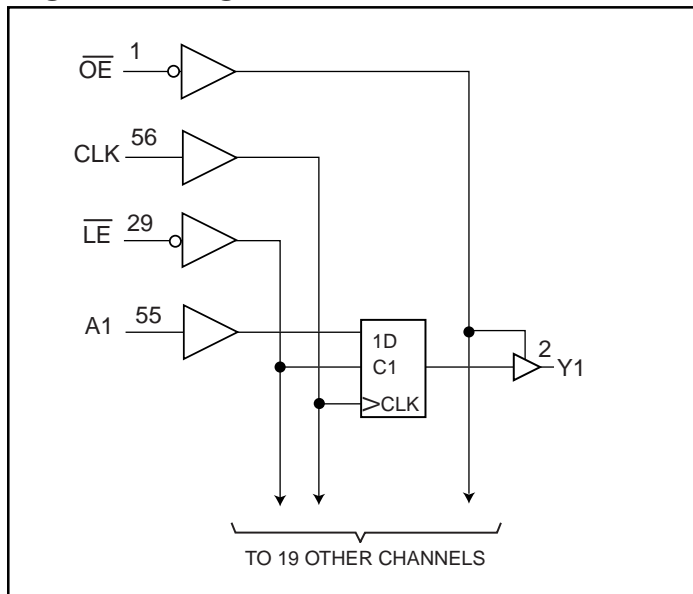
**Product Description**

Pericom Semiconductor's PI74ALVC series of logic circuits are produced using the Company's advanced submicron CMOS technology, achieving industry leading speed.

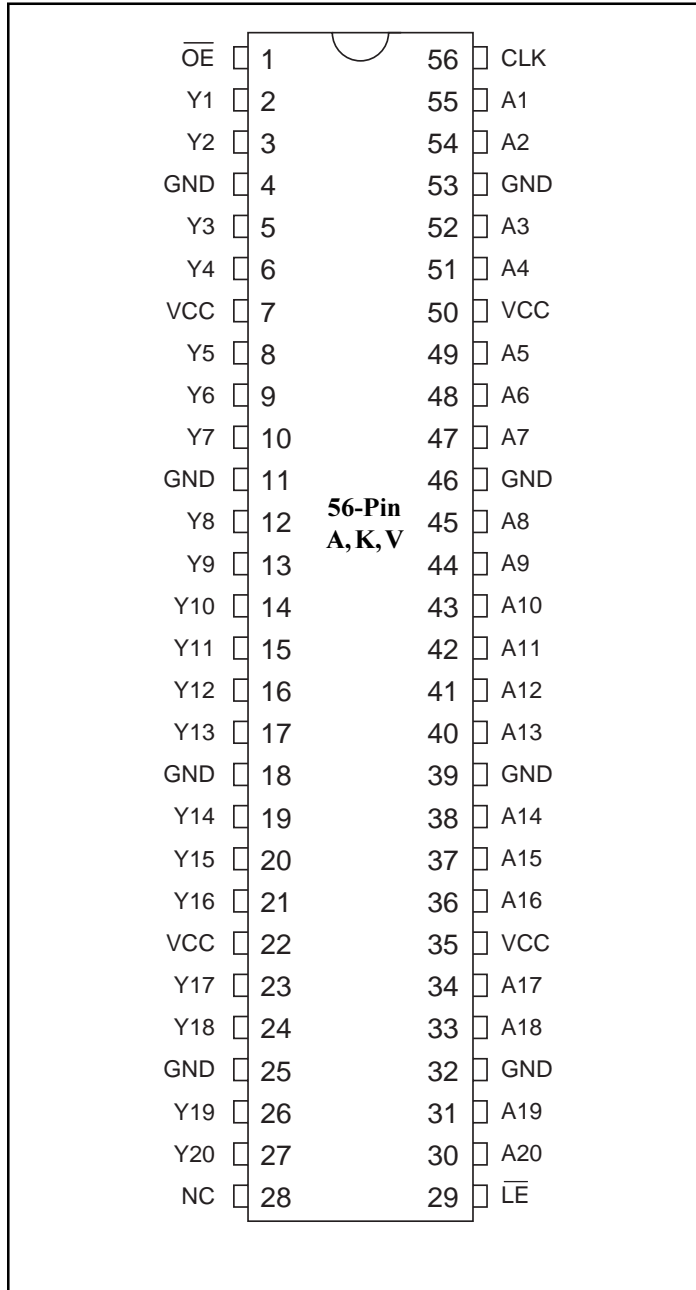
The 20-bit PI74ALVC162836 universal bus driver is designed for 2.3V to 3.6V  $V_{CC}$  operation.

Data flow from A to Y is controlled by the Output Enable ( $\overline{OE}$ ) input. The device operates in the transparent mode when the latch-enable ( $\overline{LE}$ ) input is LOW. When  $\overline{LE}$  is HIGH, the A data is latched if the clock (CLK) input is held at a high or low logic level. If  $\overline{LE}$  is HIGH, the A data is stored in the latch/flip-flop on the low-to-high transition of CLK. When  $\overline{OE}$  is HIGH, the outputs are in the high-impedance state, but all the inputs are enabled and data is capable of being stored in the register.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

**Logic Block Diagram**

**Product Pin Description**

Pin Name	Description
$\overline{OE}$	Output Enable Input (Active LOW)
$\overline{LE}$	Latch Enable (Active LOW)
CLK	Clock Input
A	Data Input
Y	Data Output
GND	Ground
$V_{CC}$	Power

**Product Pin Configuration**

**Truth Table<sup>(1)</sup>**

Inputs				Outputs Y
$\overline{OE}$	$\overline{LE}$	CLK	A	
H	X	X	X	Z
L	L	X	L	L
L	L	X	H	H
L	H	↑	L	L
L	H	↑	H	H
L	H	L or H	X	Yo <sup>(2)</sup>

**Note:**

- H = High Signal Level  
 L = Low Signal Level  
 Z = High Impedance  
 ↑ = Transition LOW-to-HIGH  
 X = Irrelevant
- Output level before the indicated steady-state input conditions were established.

### Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature .....	-65°C to +150°C
Ambient Temperature with Power Applied .....	-40°C to +85°C
Input Voltage Range, $V_{IN}$ .....	-0.5V to $V_{CC}+0.5V$
Output Voltage Range, $V_{OUT}$ .....	-0.5V to $V_{CC}+0.5V$
DC Input Voltage .....	-0.5V to +5.0V
DC Output Current .....	100 mA
Power Dissipation .....	1.0W

**Note:**

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

### Recommended Operating Conditions<sup>(1)</sup>

Parameters	Description	Test Conditions	Min.	Typ.	Max.	Units
$V_{CC}$	Supply Voltage		2.3		3.6	V
$V_{IH}$	Input HIGH Voltage	$V_{CC} = 2.3V$ to $2.7V$	1.7			
		$V_{CC} = 2.7V$ to $3.6V$	2.0			
$V_{IL}$	Input LOW Voltage	$V_{CC} = 2.3V$ to $2.7V$			0.7	
		$V_{CC} = 2.7V$ to $3.6V$			0.8	
$V_{IN}$	Input Voltage		0		$V_{CC}$	
$V_{OUT}$	Output Voltage		0		$V_{CC}$	
$I_{OH}$	High-level Output Current	$V_{CC} = 2.3V$			-6	mA
		$V_{CC} = 2.7V$			-8	
		$V_{CC} = 3.0V$			-12	
$I_{OL}$	Low-level Output Current	$V_{CC} = 2.3V$			6	
		$V_{CC} = 2.7V$			8	
		$V_{CC} = 3.0V$			12	
$T_A$	Operating Free-Air Temperature		-40		85	°C

**Note:**

- Unused control inputs must be held HIGH or LOW to prevent them from floating.

**DC Electrical Characteristics** (Over the Operating Range,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 3.3\text{V} \pm 10\%$ )

Parameters	Test Conditions		$V_{CC}^{(1)}$	Min. <sup>(1)</sup>	Typ. <sup>(2)</sup>	Max. <sup>(1)</sup>	Units
$V_{OH}$	$I_{OH} = -100\mu\text{A}$		Min. to Max.	$V_{CC} - 0.2$			V
	$I_{OH} = -4\text{mA}$	$V_{IH} = 1.7\text{V}$	2.3V	1.9			
	$I_{OH} = -6\text{mA}$	$V_{IH} = 1.7\text{V}$	2.3V	1.7			
		$V_{IH} = 2.0\text{V}$	3.0V	2.4			
	$I_{OH} = -8\text{mA}$	$V_{IH} = 2.0\text{V}$	2.7V	2.0			
	$I_{OH} = -12\text{mA}$	$V_{IH} = 2.0\text{V}$	3.0V	2.0			
$V_{OL}$	$I_{OH} = 100\mu\text{A}$		Min. to Max.			0.2	V
	$I_{OH} = 4\text{mA}$	$V_{IL} = 0.7\text{V}$	2.3V			0.4	
	$I_{OH} = 6\text{mA}$	$V_{IL} = 0.7\text{V}$	2.3V			0.55	
		$V_{IL} = 0.8\text{V}$	3.0V			0.55	
	$I_{OH} = 8\text{mA}$	$V_{IL} = 0.8\text{V}$	2.7V			0.6	
	$I_{OH} = 12\text{mA}$	$V_{IL} = 0.8\text{V}$	3.0V			0.8	
$I_I$	$V_I = V_{CC}$ OR GND		3.6V			$\pm 5$	$\mu\text{A}$
$I_{OZ}^{(4)}$	$V_O = V_{CC}$ OR GND		3.6V			$\pm 10$	
$I_{CC}$	$V_I = V_{CC}$ OR GND		3.6V			40	
$\Delta I_{CC}$	One input at $V_{CC} - 0.6\text{V}$ , Other inputs at $V_{CC}$ OR GND		3V to 3.6V			750	
$C_I$ Control Inputs	$V_I = V_{CC}$ OR GND		3.3V		5		pF
Data Input	$V_O = V_{CC}$ OR GND		3.3V		5.5		
$C_O$ Outputs	$V_O = V_{CC}$ OR GND		3.3V		7.5		

**Notes:**

1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device type.
2. Typical values are at  $V_{CC} = 3.3\text{V}$ ,  $+25^\circ\text{C}$  ambient and maximum loading.
3. For I/O ports, the  $I_{OZ}$  includes the input leakage current.

**Timing Requirements over Operating Range**

Parameters	Description	$V_{CC} = 2.5\text{V} \pm 0.2\text{V}$		$V_{CC} = 2.7\text{V}$		$V_{CC} = 3.3\text{V} \pm 0.3\text{V}$		Units
		Min.	Max.	Min.	Max.	Min.	Max.	
$f_{\text{CLOCK}}$	Clock Frequency	0	150	0	150	0	150	MHz
$t_W$ Pulse Duration	LE Low	3.3		3.3		3.3		ns
	CLK High or Low	3.3		3.3		3.3		
$t_{\text{SU}}$ Setup Time	Data before $\text{CLK}\uparrow$	1.4		1.7		1.5		
	Data before $\text{LE}\uparrow$ , CLK High	1.2		1.6		1.3		
	Data before $\text{LE}\uparrow$ , CLK Low	1.4		1.5		1.2		
$t_H$ Hold Time	Data after $\text{CLK}\uparrow$	0.9		0.9		0.7		
	Data after $\text{LE}\uparrow$ , CLK High or Low	1.1		1.1		1.1		
$\Delta t/\Delta V^{(1)}$	Input Transition Rise or Fall	0	10	0	10	0	10	ns/V

**Note:**

1. Unused control inputs must be held HIGH or LOW to prevent them from floating.

**Switching Characteristics Over Operating Range<sup>(1)</sup>**

Parameters	From (Input)	To (Output)	V <sub>CC</sub> = 2.5V ±0.2V		V <sub>CC</sub> = 2.7V		V <sub>CC</sub> = 3.3 V ±0. V		Units
			Min.	Max.	Min.	Max.	Min.	Max.	
f <sub>MAX</sub>			150		150		150		MHz
t <sub>PD</sub>	A	Y	1	4.4		4.6	1.2	4.0	ns
t <sub>PD</sub>	$\overline{LE}$	Y	1.1	5.8		6.1	1.4	5.1	
t <sub>PD</sub>	CLK	Y	1.0	5.2		5.5	1.1	4.5	
t <sub>EN</sub>	$\overline{OE}$	Y	1.1	6.4		6.5	1.2	5.5	
t <sub>DIS</sub>	$\overline{OE}$	Y	1	4.7		5.2	1.7	5.1	

**Notes:**

1. Unused control inputs must be held HIGH or LOW to prevent them from floating.

**Operating Characteristics, T<sub>A</sub> = 25°C**

Parameters		Test Conditions	V <sub>CC</sub> = 2.5V ±0.2V	V <sub>CC</sub> = 3.3V ±0.3V	Units
			Typical	Typical	
C <sub>PD</sub> Power Dissipation Capacitance	Outputs Enabled	C <sub>L</sub> = 50pF, F = 10 MHz	31	36	pF
	Outputs Disabled		7	11	